

Notice of References Cited

Application/Control No.

09/496,506

Applicant(s)/Patent Under

Reexamination

NAYFEH ET AL.

Examiner

Sara W. Cran

Art Unit

2811

Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
A	US-5,714,766	02-1998	Chen et al.	257	17
B	US-5,932,889	08-1999	Matsumura et al.	257	14
C	US-				
D	US-				
E	US-				
F	US-				
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
N						
O						
P						
Q						
R						
S						
T						

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
U	Tiware, S., et al., "A silicon nanocrystals based memory," Appl. Phys. Lett. 68(10), 4 March 1996, pp 1377-79.		
V			
W			
X			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.